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To Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number. Substitute for form 1449A/PTO Complete if Known INFORMATION DISCLOSURE RECEIVED TC 13 2003 09/901001 **Application Number** STATEMENT BY APPLICANT (Use as many sheets and necessary) July 9, 2001 Filing Date Ahn, Kie **First Named Inventor Group Art Unit** 1756 AUG 0 8 2003 **Examiner Name** Duda, Kathleen Attorney Docket No: 1303.016US1 Sheet 1 of 1

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